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Photosensitive Schottky barrier diode behavior of a semiconducting Co(III)—Na complex with a compartmental Schiff base ligand†

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The opto-electronic properties of an X-ray characterized, end-to-end azide bridged cobalt($_{\rm III}$)-sodium complex, [(N₃)CoLNa(N₃)]_n, have been investigated in detail. The complex is found to be a direct semiconductor material as confirmed by determining the band gap of this complex by experimental as well as theoretical studies. The complex has also been used to construct a photosensitive Schottky device. Optical conductivity, calculated from the DFT study, has been used to analyze how the conductivity of the material changes upon illumination. The electrical conductivity and concomitantly, the photoconductivity of the material increase as a consequence of photon absorption.

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Introduction

Various synthetic inorganic chemistry groups are engaged now-a-days in preparing diverse CPs (coordination polymers) and MOFs (metal organic frameworks) and exploring their electrical conductivity and charge transport properties.1-5 Opto-electronic properties of many such complexes were investigated and found to be interesting.6-9 For example, our group has reported cadmium(II) and copper(II) based coordination polymers, both showing photosensitivity with subsequent on/off ratio.10,11 Any semiconducting material showing a rectifying nature in metal-semiconductor junction may be used to fabricate a Schottky diode, which is a wellknown opto-electronic device. Ghoshal et al. reported a cadmium(II) based metal organic framework that can behave as a Schottky barrier diode.12 Two zinc(II) based metal organic frameworks were also synthesised by the same group and both of these MOFs show p-type semiconductor behaviour. 13 Two cadmium(II) based metal organic frameworks behaving as photosensitive Schottky diode have been reported by Roy et al.14,15 Synthesis and characterization of another cadmium(II) based coordination polymer exhibiting photosensitive Schottky barrier diode behaviour were reported by Saha et

Although many metal complexes have been used to fabricate photosensitive Schottky barrier diode, best to our knowledge, there is no report in the literature to use any X-ray characterized cobalt(III) complex for the fabrication of any opto-electronic device till date. In the present work, we have prepared a heteronuclear cobalt(III)-sodium complex and investigated its opto-electronic property. The band gap of the synthesized material in the solid state has been determined by experimental measurements and compared with the theoretical value obtained from DFT calculations. The band gap indicates that the complex belongs to the semiconductor family. The reason for using cobalt(III) complex is that many cobalt(III) complexes have already been used to artificially model photosynthesis systems.20-22 Thus they have the potential to utilize light energy. This observation leads us to explore the potential of this cobalt(III) complex in fabricating a photosensitive Schottky device. DFT study has also been performed to evaluate optical conductivity which has then been used to analyze the changes in conductivity of the material upon illumination. The electrical conductivity and photoconductivity of the material increase in presence of light as a consequence of photon absorption.

at.¹6 Synthesis of a copper(II) based 1D coordination polymer and its application in Schottky devices have been reported by Mir *et al.*¹7 Sinha *et al.* have reported three zinc(II) based intercatenated CPs behaving as Schottky diode.¹8 Photosensitive Schottky diode character of any material based device may be recognized from the non-linear rectifying behaviour of its I–V characteristics measured under dark and illumination conditions. For example, heterometallic nickel(II)/lead(II) and nickel(II)/mercury(II) complexes were used by our group to fabricate photosensitive Schottky barrier diodes.¹9

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[†] Electronic supplementary information (ESI) available: The complete experimental section, analysis of Hirshfeld surfaces, X-ray diffraction of powdered material, spectral and magnetic characterization of the complex are given. CCDC 1866271. For ESI and crystallographic data in CIF or other electronic format see DOI: 10.1039/c9ra06354d

Results and discussion

Synthesis of the complex

Paper

The potentially hexadentate Schiff base ligand, H_2L , was synthesized by the 1:2 condensation of 2,2-dimethyl-1,3-propanediamine with 5-bromo-3-methoxysalicylaldehyde in acetonitrile following the literature method. ^{23,24} The acetonitrile solution of ligand (H_2L) was then made to react with cobalt(II) acetate tetrahydrate and sodium azide to prepare the polymeric complex, $[(N_3)CoLNa(N_3)]_n$, containing the potentially hexadentate deprotonated Schiff base ligand and coordinated azide as co-ligand (Scheme 1). Single crystal X-ray class dark brown single crystals of the complex were obtained from the 1:1 methanol–acetonitrile solution.

Description of the solid-state structure

Single crystal X-ray crystallographic data analysis reveals that the complex crystallizes in the monoclinic $P2_1/c$ space group and presents a 1D coordination network. The complex consists of a zigzag chain assembly with the repeating heterobinuclear neutral unit, [(N₃)CoLNa(N₃)], joined through two end-to-end azide bridge. In each hetero-binuclear unit, the cobalt(III) centre resides in the inner salen-type cavity, while sodium centre resides in the open and larger position of the deprotonated compartmental Schiff base ligand, L²⁻. A perspective view of the complex is illustrated in Fig. 1. The metal centers are bridged by two phenoxo oxygen atoms, O(1) and O(2), of the Schiff base ligand, forming a CoO₂Na core. Within the core Co(1)-Na(1) distance is 3.453 Å and bridging angles, Co(1)-O(1)-Na(1) and Co(1)-O(2)-Na(1), are 106.58° and 106.16°, respectively. All these angles and distances are comparable with previously reported similar type heteronuclear complexes.25,26 In each hetero-binuclear unit both cobalt(III) and sodium centres are present in six-coordinate environments. The cobalt(III) centre is coordinated by two imine nitrogen atoms, N(1) and N(2), and two phenoxo oxygen atoms, O(1) and O(2), of the deprotonated Schiff base ligand. One end-to-end bridged azide nitrogen atom, N(3) occupies the fifth coordination site. The remaining coordination site of cobalt(III) is occupied by one nitrogen atom, $N(8)^a$ from a symmetry related {symmetry transformation: a = x, 1/2 - y, -1/2 + z end-to-end bridged azide co-ligand to form a distorted octahedral geometry. While sodium centre is

coordinated by two phenoxo oxygen atoms, O(1) and O(2), and two methoxy oxygen atoms, O(3) and O(4). The remaining two coordination sites are occupied by two end-to-end bridged azide nitrogen atoms, $N(5)^a$ and N(6). The bond angles around cobalt(III) centre are slightly distorted from the ideal values of 90° (for cis angles) and 180° (for trans angles) for the octahedral geometry, indicating the coordination geometry to be slightly distorted in nature. On the contrary, bond angles around sodium centre are highly deviated from the ideal values, referring a highly distorted geometry around the alkali metal centre. The packing diagram indicates that hetero-binuclear units are hold together to form a onedimensional infinite zigzag chain through two end-to-end azide bridge between cobalt(III)-sodium centres (Fig. 2). The saturated six-membered chelate ring [Co(1)-N(1)-C(9)-C(10)-C(11)-N(2)] has an half-chair conformation with puckering parameters^{27,28} $Q = 0.532(4) \text{ Å}, \theta = 22.5(3)^{\circ} \text{ and } \phi =$ 173.8(9)°.

Except for the end-to-end azide bridge between the heterobinuclear units, there are some other interesting bromine... π interactions in the solid state of the complex. Bromine atoms, Br(1), attached to phenyl carbon atom, C(17), and Br(2), attached to phenyl carbon atom, C(4), are involved in intermolecular bromine $\cdots \pi$ interaction with the symmetry related (1 + x,y,1 + z) phenyl ring, Cg4 [C(2)-C(3)-C(4)-C(5)-C(6)-C(7)] and symmetry related (-1 + x,y,z) phenyl ring, Cg5 [C(15)-C(16)-C(17)-C(18)-C(19)-C(20)]. The complex forms a 2D sheet structure by these interactions (Fig. 3). The details of these bromine $\cdots\pi$ interactions are summarized in Table 1. It should be emphasized that C-Br $\cdots\pi$ interactions have been described in several theoretical29,30 and experimental works.31 Especially relevant is the existence of $Br \cdots \pi$ interactions in the cytochrome P 450 active site.32 It has been demonstrated that this interaction has a crucial role in substrate selectivity and orientation in the active site. The geometrical features of the Br $\cdots\pi$ interaction are comparable to those already reported in the aforementioned experimental and theoretical works.

Optical characterization

To measure the optical band gap, the UV-vis absorption spectra of the complex is recorded and shown in Fig. 4 (inset). The optical band gap energy $(E_{\rm g})$ of the complex is calculated from Tauc's equation:^{33,34}

Scheme 1 Synthetic route to the complex.

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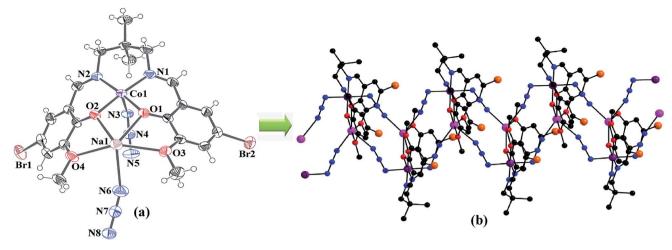


Fig. 1 (a) ORTEP diagram with 40% probability ellipsoid of hetero-binuclear unit of the complex with the corresponding atom labeling scheme; (b) polymeric chain of the complex. Hydrogen atoms are omitted for clarity.

$$(\alpha h \nu) = A(h \nu - E_{g})^{n} \tag{1}$$

Here, A is a constant which is considered as 1 for general case. Absorption coefficient is denoted by α and band gap is represented by $E_{\rm g}$. h is Planck's constant, ν is the frequency of light and the exponent n is the electron transition processes dependent constant. The plot of $(\alpha h \nu)^2 vs. h \nu$ of the synthesized complex is portrayed in Fig. 4. The value of exponent n was taken as $\frac{1}{2}$ for direct band gap. To check the value of n as $\frac{1}{2}$, eqn (1) may be written as:³⁵

$$\frac{\mathrm{d}[\ln(\alpha h\nu)]}{\mathrm{d}[h\nu]} = \frac{n}{h\nu - E_{\mathrm{g}}} \tag{2}$$

In the plot of $d[\ln(\alpha h \nu)]/d[h \nu]$ *versus* $h \nu$ (Fig. 5), a discontinuity is observed. The discontinuity at a particular energy provides the approximate value of band gap (2.81 eV). Using the value of approximate band gap (E_g) , $\ln[(\alpha h \nu)]$ νs . $\ln[h \nu - E_g]$ is plotted (inset of Fig. 5). The value of n is then obtained from the slope of the curve. Here the slope (\sim 0.5) proposes that the transition is directly allowed for this material. The value of optical direct band gap of the complex is evaluated as 2.74 eV from Tauc's plot.

Electrical characterization

Fig. 6a shows the current–voltage characteristics of ITO/complex/ Al device under dark and photo illumination condition.

Both the characteristic curves indicate the rectifying nature, with on/off current ratio 25.57 under dark and 137.49 under light at applied bias potential \pm 2.0 V. The $\it I-V$ characteristic curves were analyzed by the thermionic emission (TE) theory. Common temperature conductivity of the device under dark and illumination condition was calculated as 0.88 \times 10 $^{-8}$ Sm $^{-1}$ and 2.38 \times 10 $^{-8}$ Sm $^{-1}$. The photosensitivity of the device was found to be 1.45 at 1000 W m $^{-2}$ illumination. For investigation of the photo detector response, we measured the transient photocurrent of the device under an illumination of 1000 W m $^{-2}$ at bias voltage +2 V, which is represented in Fig. 6b. This transient photocurrent response mainly discloses the conductance value and the number of free carrier produce at the time of light irradiation in the semiconductor.

The diode analysis was performed with the help of following equations based on TE theory

$$I = I_0 \left[\exp\left(\frac{qV}{\eta kT}\right) - 1 \right] \tag{3}$$

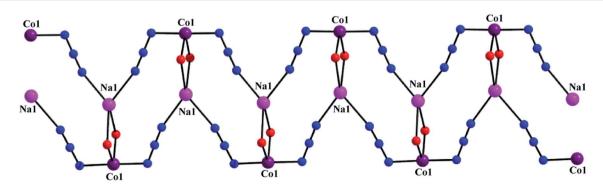


Fig. 2 One-dimensional infinite zigzag chain through two end-to-end azide bridge between cobalt(III) – sodium centres.

Paper

Fig. 3 (a) Intermolecular bromine $\cdots\pi$ interaction in the complex; (b) formation of 2D sheet structure through intermolecular bromine $\cdots\pi$ interactions.

(b)

Table 1 Geometric features (distances in Å and angles in °) of the Br \cdots π interactions obtained for the complex^a

C-Br···Cg(ring)	Br···Cg (Å)	С-Вг…Сд (°)	C···Cg (Å)
C(17)-Br (1) ···Cg (4) ^b	3.6938(14)	160.55(10)	5.523(4)
C(4)-Br (2) ···Cg (5) ^c	3.6263(15)	159.87(11)	5.453(3)

^a Symmetry transformations: b = 1 + x,y,1 + z and c = -1 + x,y,z. Cg(4) = centre of gravity of the ring [C(2)-C(3)-C(4)-C(5)-C(6)-C(7)] and Cg(5) = centre of gravity of the ring [C(15)-C(16)-C(17)-C(18)-C(19)-C(20)].

$$I_0 = AA^*T^2 \exp\left(\frac{-q\phi_b}{kT}\right) \tag{4}$$

$$\eta = \left(\frac{q}{kT}\right) \frac{\mathrm{d}V}{\mathrm{d}\ln(I)} \tag{5}$$

where I_0 , q, k, T, A, A^* , η and ϕ_b stand for the reverse saturation current, electronic charge, Boltzmann constant, absolute temperature, the effective diode area, Richardson constant,

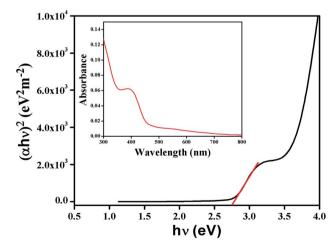


Fig. 4 Tauc's plot and UV-vis absorption spectra (inset) of the complex.

ideality factor and the barrier potential height respectively. The effective diode area was considered as $7.065 \times 10^{-6} \text{ m}^2$ and the Richardson constant was considered as $1.20 \times 10^6 \text{ A K}^{-2} \text{ m}^{-2}$.

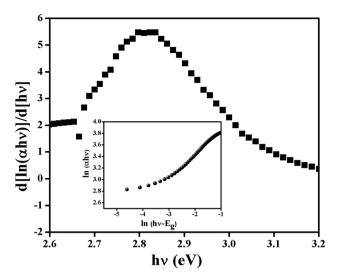


Fig. 5 d[ln($\alpha h \gamma$)]/d[$h \gamma$] vs. $h \gamma$ and ln($\alpha h \gamma$) vs. ln($h \gamma - E_{\alpha}$) plot.

The series resistance, ideality factor and barrier potential height is determined by using Cheung's equations^{38,39}

$$\frac{\mathrm{d}V}{\mathrm{d}\ln(I)} = \frac{\eta kT}{q} + IR_{\mathrm{s}} \tag{6}$$

$$H(I) = V - \left(\frac{\eta kT}{q}\right) \ln\left(\frac{I_0}{AA^*T^2}\right) \tag{7}$$

$$H(I) = IR_{\rm S} + \eta \phi_{\rm b} \tag{8}$$

The series resistance and ideality factor was determined from the slope and intercept of $dV/d \ln(I) vs. I$ plot for dark and light condition, which is portrayed in Fig. 7. The potential barrier height was evaluated from the *y*-axis intercept of H(I) vs. I curve (Fig. 7). The slope of this plot also furnished a second determination of the series resistance. The obtained values of

ideality factor, barrier height and series resistance are listed in Table 2. The ideality factor of the device under dark condition indicated the deviation from ideal behavior due to high probability of electron and hole recombination in the depletion region or occurrence of tunneling current or presence of inhomogenities of Schottky barrier height or existence of interface states^{40,41} whereas, upon light irradiation the value approached to unity. We have also studied temperature and thickness dependent current–voltage characteristics for our synthesized complex (see ESI†).

To get better insight of the charge transport mechanism in the junction we have analyzed the I-V characteristic by employing space charge limited current (SCLC) theory. In this purpose we have looked into the logarithm current vs. voltage (I-V) curves under dark and photo illumination (Fig. 8).

The region-I indicates the ohmic behavior (since $I \propto V$) in the low voltage region. This came across due to the occurrence of series resistance of the device, whereas, the region II corresponds to the higher ordered magnitude of slope, exhibits variation of current with square of forward bias voltage ($I \propto V^2$). In this region the current originated from space charge, designated as space charge limit current (SCLC) mechanism by discrete trapping level. The region-III is influenced by SCLC mechanism ($I \propto V^m$) due to exponential distribution of traps. The electron mobility under dark and photo illumination was estimated as $7.90 \times 10^{-10} \, \mathrm{m^2 \, V^{-1}} \, \mathrm{s^{-1}}$ and $22.59 \times 10^{-10} \, \mathrm{m^2 \, V^{-1}} \, \mathrm{s^{-1}}$ from $Ivs. V^2$ plot (Fig. 9) using by Mott-Gurney space-charge-limited-current (SCLC) equation:

$$I = \frac{9\mu_{\rm eff}\varepsilon_0\varepsilon_r A}{8} \left(\frac{V^2}{d^3}\right) \tag{9}$$

where, I is the current density, ε_0 is the permittivity of free space and ε_r the dielectric constant. The value of dielectric constant of the material was measured as 3.43 from capacitance νs . frequency plot (C–f) (Fig. 10) by using the equation:⁴⁴

$$\varepsilon_{\rm r} = \frac{Cd}{\varepsilon_0 A} \tag{10}$$

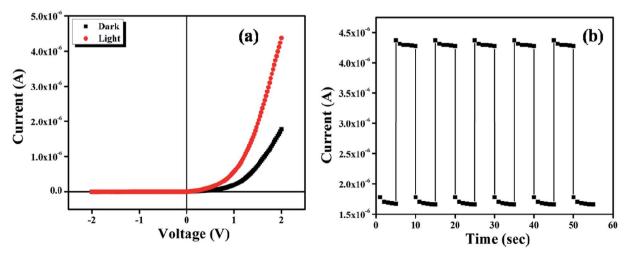


Fig. 6 (a) Current-Voltage (I-V) characteristic curve for the complex under dark and light condition; (b) transient photocurrent response.

Paper

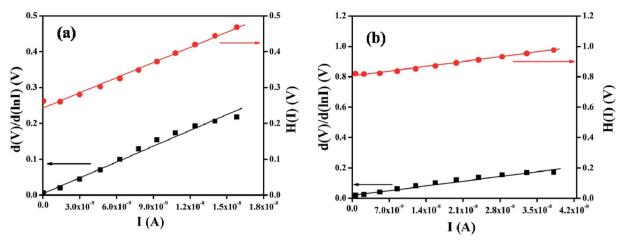


Fig. 7 $dV/d \ln I vs. I$ and H(I) vs. I curve for the complex based Schottky barrier diode under (a) dark and (b) photo condition.

where, C is the capacitance (at saturation), d is the thickness of the film and rest are same as defined previously.

Transit time (τ) is defined as the time, which is required by a carrier to travel from anode to cathode. It can be expressed as the summation of average total time spent by each electron as a free carrier plus total time spent in the tarp. 45 The transit time (τ) of the charge carrier is estimated with the help of following equation:46

$$\tau = \frac{9\varepsilon_0\varepsilon_r A}{8d} \left(\frac{V}{I}\right) \tag{11}$$

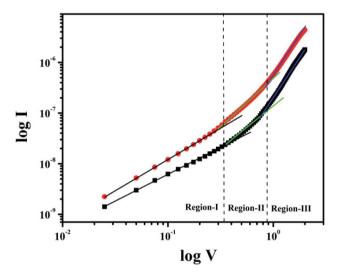
The diffusion length of the charge carrier was calculated from Einstein-Smoluchowski equation:47

$$\mu_{\text{eff}} = \frac{qD}{kT} \tag{12}$$

and

$$L_{\rm D} = \sqrt{2D\tau} \tag{13}$$

where, D is the diffusion co-efficient and $L_{\rm D}$ is the diffusion length of the charge carrier. It has been observed that after light soaking the mobility of the charge carrier is increased up to 185%. The longer transit time in dark condition indicates the higher trapping probabilities. Under the illumination condition lowering of transit time leads to reduce the trapping time due to the higher carrier mobility. 48,49 Diffusion length of the carriers also improved under an illumination condition, which points out that our material, can be a good potential candidate in



log I versus log V plot under dark and light condition.

photovoltaic device application. All the obtained values of charge transport parameters for Al/complex/ITO are listed in Table 3.

Structure-property relationship

The complex is a one-dimensional complex (Fig. 2) where the asymmetric units are bridged via end-to-end azide moieties. Intermolecular bromine $\cdots\pi$ interaction in the complex form

Table 2 Schottky diode parameters

Conductivity (σ) Measured condition (Sm^{-1})	$d(V)/d(\ln I)$ vs. I g		graph	H(I) vs. I graph		
	(σ)	Photosensitivity	Ideality factor (η)	Series resistance (R_S) (ohm)	Barrier height (ϕ_b) (eV)	Series resistance (R_S) (ohm)
Dark Light	0.88×10^{-8} 2.38×10^{-8}	1.45	0.27 0.91	1.45×10^{7} 4.39×10^{6}	0.90 0.87	1.40×10^{7} 4.41×10^{6}

RSC Advances

4.0x10 3.5x10⁻⁷ 3.0x10⁻⁷ 2.5x10 2.0x10 1.5x10 1.0x10 5.0x10 0.40 0.45 0.50 0.55 0.60 0.65 0.70 0.75 $V^2(V)$

Fig. 9 I vs. V^2 plot of SCLC region under dark and photo condition

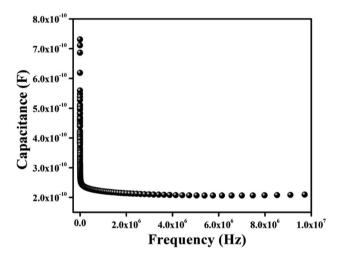


Fig. 10 Capacitance vs. frequency (C-f) plot for the complex.

a 2D sheet structure (Fig. 3). Formation of this supramolecular structure is most likely responsible for the photosensitivity of the complex. The complex can sense whether the light source is switched on or switched off (Fig. 6b, 7a, 7b, 8 and 9). Thus, it may be concluded that the complex may be used to prepare a suitable opto-electronic device with the help of which with switching of the photocurrent may be possible time after time without any drop of the on/off ratio. The complex may, therefore, find applications in the fabrication of photo switch devices. A probable justification for this activity may be given as

following. The organic ligand is electron rich and may therefore act as the supplier of negative charge upon photoexcitation, while the inorganic $Na-N_3-Co(III)$ unit (which is most probably electron deficient as both sodium and cobalt are in positive oxidation states) behaves as an acceptor of electron.

Theoretical study

The experimental crystal lattice has been chosen as started point for optimizing the atomic positions of the complex in the solid state (see ESI for full computational details†). Crystal structure analysis has been done by standard band theory and total/partial density of states calculation, giving a band gap value of 1.80 eV. Since this value is significantly lower than the experimental one as common in theoretically predicted band gaps calculated using DFT,⁵⁰ we have applied a conventional scissor operator of +0.94 eV to the theoretical properties reported in this work. Fig. 11 shows the plot of the valence and conduction bands which indicates that the complex is a direct semiconductor.

The total and partial DOS calculation shown in Fig. 12 reveals that the valence bands are mainly dominated by the porbitals of the ligands (both organic ligand and azide) and to a lesser extent by the d-orbitals of the cobalt atoms. In addition, the main contributors to the conduction band are the p-orbitals of the Schiff base ligand (H_2L) and the d-orbitals of the cobalt atoms. The azide ligand and sodium cations have little influence on the conduction bands.

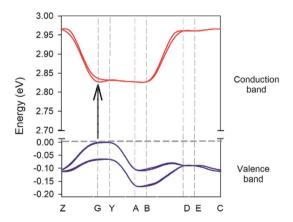


Fig. 11 Electronic band structure of the ground state of the complex crystal. Points of high symmetry in the first Brillouin zone are labeled as follows: Z = (0, 0, 0.5); G = (0, 0, 0); Y = (0, 0.5, 0); A = (-0.5, 0.5, 0.5) and C = (0, 0.5, 0.5). The energy positions of the all the conduction bands are shifted upward by 0.94 eV through a scissors operator.

Table 3 SCLC/charge transport parameters

Measured condition	SCLC conductivity $(\sigma) (Sm^{-1})$	Carrier mobility $(\mu) \times 10^{-10} \text{ m}^2 \text{ v}^{-1} \text{ s}^{-1}$	Transit time $(\tau) \times 10^{-4} (\text{sec})$	$\mu \tau \times 10^{-14} (\mathrm{m^2 v^{-1}})$	Diffusion coefficient $(D) \times 10^{-12} (\text{m}^2 \text{ s}^{-1})$	
Dark	2.31×10^{-7} 5.55×10^{-7}	7.90	8.55	67.67	20.39	186
Light		22.59	3.09	69.96	58.29	190

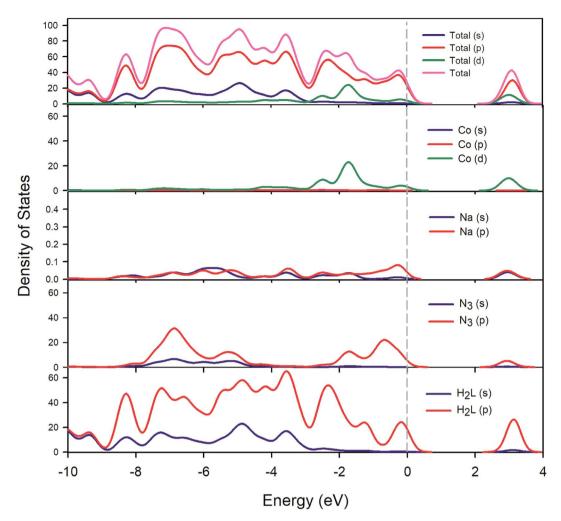


Fig. 12 Calculated total and partial density of states of cobalt (Co), sodium (Na), azide (N₃) and Schiff base (H₂L).

Fig. 13 and 14 represent the optical properties of the solid-state material. They provide some information regarding the character of the bands. In each material, the frequency dependence of an incident photon can be studied by computing the dielectric function $\varepsilon(\omega)$. The real part of $\varepsilon(\omega)$ gives information about the polarization degree of the material upon the application of an electric

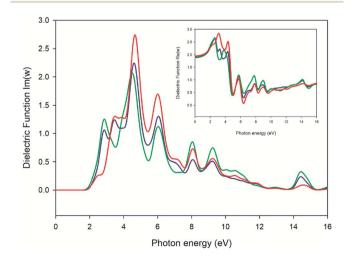


Fig. 13 Plot of real (small square) and imaginary (big square) parts of the dielectric function *versus* the photon energy of the crystal. Blue, green and red lines specify the incident direction of unpolarized radiation in the 'x', 'y' and 'z' directions of the crystal, respectively.

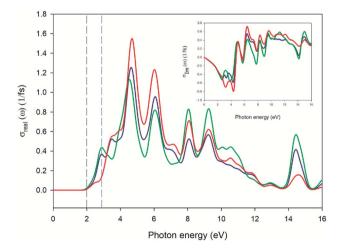


Fig. 14 Plot of real (big square) and imaginary (small square) parts of optical conductivity *versus* the photon energy of the crystal. Blue, green and red lines specify the incident direction of unpolarized radiation in the 'x', 'y' and 'z' directions of the crystal, respectively.

field. The imaginary part is a good indicator of the absorption in the material of the incident photon. We have used the computed band structure to measure the optical response. To do so, we have selected a photon energy range of 0 to 16 eV. The peaks can be assigned to electronic transitions from the top of the valence band to the low energy in the conduction band. Due to the anisotropy of the crystal we have decomposed the dielectric constant in three main directions where the light may fall on the crystal (ε_{rr} , ε_{vv} , ε_{zz}) (see ESI Fig. S1†). In this case, two of the directions (blue and green line of Fig. 13) represent a first maximum in 2.9 eV, while the ε_{zz} direction is three times lower than the rest of the components. The imaginary parts of dielectric functions have a main peak for complex at 4.5 eV. Fig. 14 represents the optical conductivity $[\sigma(\omega)]$. This property is useful to analyze how the conductivity of the material changes upon illumination. As can be seen, near of 2.0 eV (black dashed line) $\sigma(\omega)$ starts to grow finding the first maximum at 2.9 eV (blue dashed line). The electrical conductivity and, concomitantly, the photoconductivity of the material increase as a consequence of photon absorption.

Conclusions

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In this work, we illustrate the opto-electronic properties of a new heteronuclear cobalt(m)-sodium complex. The band gap of this semiconductor material in the solid state has been determined by experimental as well as DFT calculations and it confirms that it is a direct semiconductor. We have also shown the potential of this heteronuclear complex in fabricating a photosensitive Schottky device. Theoretical studies have been used to rationalize the experimental observations and to provide an explanation to the enhanced conductivity of the complex upon illumination. It is a promising candidate to have applications in CP semiconducting research and in the fabrication of optoelectronic devices.

Conflicts of interest

There are no conflicts to declare.

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